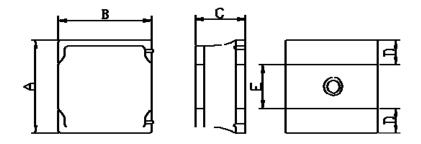


## **FEATRLRES**

- This specification applies Low Profile Power Inductors.
- 100% Lead(Pb) & Halogen-Free and RoHS compliant.

### CONFIGRLRATIONS & DIMENSIONS (unit in mm)



Туре	Α	В	С	D	E	G	н	I
HNR3010TF	3.0±0.2	$3.0 \pm 0.2$	1.0max.	1.0 ref.	1.0 ref.	-	-	-

#### **ELECTRICAL CHARACTERISTICS**

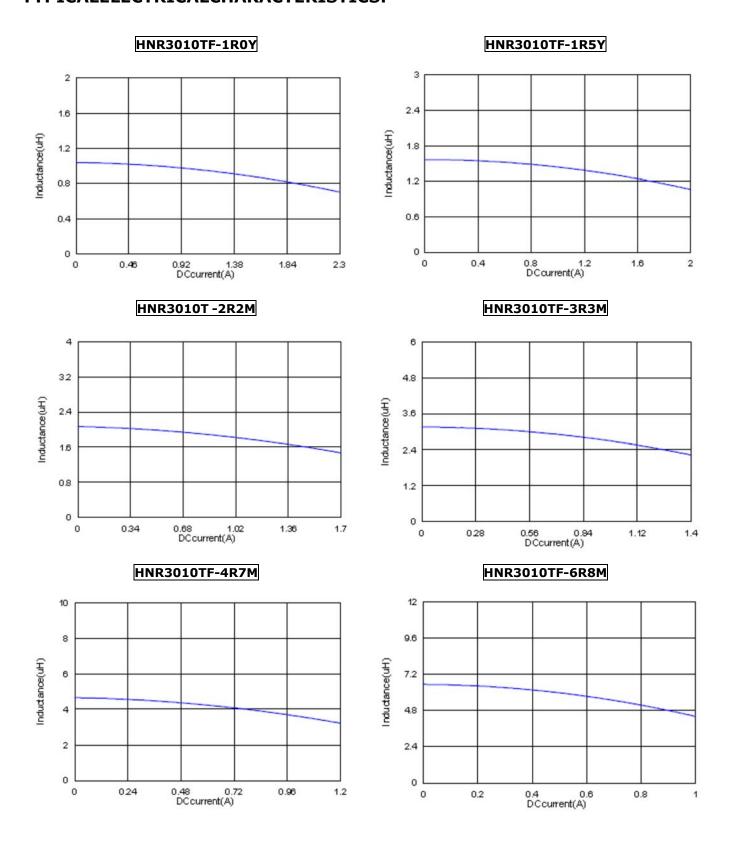
Davit Neurobau	Inductance Tolerance		Test	DCR	I sat (A)	I sat (A)	I rms (A)	I rms (A)
Part Number	(uH)	(%)	Frequency (Hz)	(Ω) ±20%	typ.	max.	typ.	max.
HNR3010TF-1R0Y	1.0	±30%	0.1V/1M	0.055	2.20	1.80	2.50	2.10
HNR3010TF-1R5Y	1.5	±30%	0.1V/1M	0.070	2.00	1.50	2.20	1.90
HNR3010T -2R2M	2.2	±20%	0.1V/1M	0.090	1.60	1.30	2.10	1.70
HNR3010TF-3R3M	3.3	±20%	0.1V/1M	0.130	1.30	1.10	1.70	1.50
HNR3010TF-4R7M	4.7	±20%	0.1V/1M	0.170	1.20	0.90	1.50	1.30
HNR3010TF-6R8M	6.8	±20%	0.1V/1M	0.260	0.90	0.77	1.30	1.00
HNR3010TF-100M	10	±20%	0.1V/1M	0.350	0.75	0.63	1.00	0.80
HNR3010TF-150M	15	±20%	0.1V/1M	0.510	0.65	0.54	0.80	0.70
HNR3010TF-220M	22	±20%	0.1V/1M	0.750	0.55	0.43	0.75	0.60

Note:

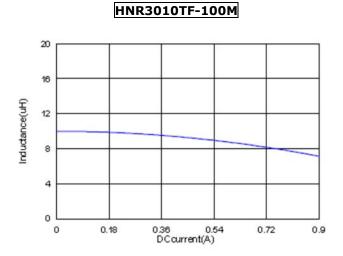
Irms: Based on temperature rise  $(\triangle T: 40^{\circ}C \text{ typ.})$ 

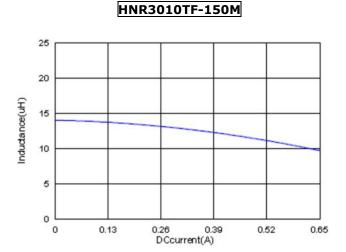


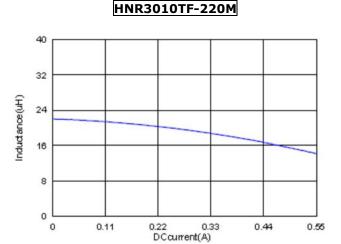
#### TYPICALELECTRICALCHARACTERISTICS:











# **Reliability and Test Condition**

Item	Performance	Test Condition			
Operating temperature	-40~+125℃ (Including self - temperature rise)				
Storage temperature	110~+40℃,50~60%RH (Product with taping) 240~+125℃ (on board)				
Electrical Performance Test					
Inductance	Refer to standard electrical characteristics list.	HP4284A,CH11025,CH3302,CH1320,CH1320S LCR Meter.			
DCR	Neier to Statitual delectrical characteristics list.	CH16502,Agilent33420A Micro-Ohm Meter.			
Saturation Current (Isat)	Approximately△L30%	Saturation DC Current (Isat) will cause L0 to drop $\triangle$ L(%)			
Heat Rated Current (Irms)  Approximately △T40℃		Heat Rated Current (Irms) will cause the coil temperature rise $\triangle T(^{\circ}C)$ . 1.Applied the allowed DC current 2.Temperature measured by digital surface thermometer			
Reliability Test					
		Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD-020DClassification Reflow Profiles)			
Life Test		Temperature : 125±2℃(Inductor)			
Life rest		Applied current : rated current			
	Appearance : No damage.	Duration : 1000±12hrs  Measured at room temperature after placing for 24±2 hrs			



	In the state of th	Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC					
	Inductance: within±10% of initial value  Q: Shall not exceed the specification value.	J-STD-020DClassification Reflow Profiles					
Load Humidity	1	Humidity: 85±2 * R.H,					
	RDC : within ±15% of initial value and shall not exceed the specification value	Temperature : 85℃±2℃					
	exceed the specimental value	Duration: 1000hrs Min. with 100% rated current Measured at room temperature after placing for 24±2 hrs					
		Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD- 020DClassification Reflow					
		Profiles  1. Baked at50°C for 25hrs, measured at room temperature after placing for 4 hrs.  2. Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in 2.5hrs.  3. Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in  2.5hrs,keep at 25°C for 2 hrs then keep at -10°C for 3 hrs					
Moisture Resistance							
		<ol> <li>Keep at 25<sup>o</sup> 80-100%RH for 15min and vibrate at the frequency of 10 to 55 Hz to 10 Hz, measure at room temperature after placing for 1~2 hrs.</li> </ol>					
Thomas		Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD- 020DClassification Reflow Profiles Condition for 1 cycle					
Thermal shock		Step1 : -40±2°C 30±5min					
		Step2 : 25±2°C ≤0.5min         Step3 : 125±2°C 30±5min					
		Number of cycles: 500 Measured at room temperature after placing for 24±2 hrs					
Vibration		Oscillation Frequency: 10 ~ 2K ~ 10Hz for 20 minutes Equipment: Vibration checker					
		Total Amplitude:1.52mm±10% Testing Time : 12 hours(20 minutes, 12 cycles each of 3 orientations).					
Bending		Shall be mounted on a FR4 substrate of the following dimensions: >=0805 inch(2012mm):40x100x1.2mm <0805 inch(2012mm):40x100x0.8mm Bending depth: >=0805 inch(2012mm):1.2mm <0805 inch(2012mm):0.8mm duration of 10 sec.					
	Appearance: No damage. Impedance: within±15% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value	Type Peak Normal Wave change (g's) (ms) Velocity (Vi)ft/sec					
Shock		SMD         50         11         Half-sine         11.3           Lead         50         11         Half-sine         11.3					
		Preheat: 150°C,60sec.₀					
Solder ability	More than 95% of the terminal electrode should be covered with solder.	Solder: Sn96.5% Ag3% Cu0.5% Temperature: 245±5℃ ∘ Flux for lead free: Rosin. 9.5% ∘ Dip time: 4±1sec ∘					
		Depth: completely cover the termination  Depth: completely cover the termination					
Resistance to Soldering Heat		Temperature ramp/immersion Number of and emersion rate heat cycles					
		260 ±5 (solder temp) 10 ±1 25mm/s ±6 mm/s 1					
	Appearance: No damage.	Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD-020DClassification Reflow Profiles With the component mounted on a PCB with the device to be tested, apply a force(>0805:1kg , <=0805:0.5kg)to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to apply a shock to the component being tested.					
Terminal Strength	Impedance: within±15% of initial value Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value e	DUT wide thick substrate press tool					
	ncerning measurement result : measurement shall be mac	de after 48 ± 2 hours of recovery under the standard					

Note: When there are questions concerning measurement result: measurement shall be made after 48 ± 2 hours of recovery under the standard condition.